

Application/Cont 09/960,398

Applicant(s)/Patent Under Reexamination KURASAWA ET AL.

Examiner Thao X Le Art Unit 2814

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,998,236	12-1999	Roeder et al.	438/104
	В	US-2002/0063274 /	07-1999	KANAYA et al.	257/310
	С	US-5,719,417 /	02-1998	Roeder et al.	257/295
	D	US-6,194,818 -,	02-2001	Sumi et al.	1/1
	E	US-6,258,459 ′	07-2001	Noguchi et al.	117/944
	F	US-2001/0015448 /	12-2000	Kawakubo et al.	257/296
	G	US-6,156,623 ~	12-2000	Hendrix et al.	438/457
	Н	US-6,265,230	07-2001	Aggarwal et al.	438/3
	1	US-6,136,639 -	10-2000	Seon, Jeong Min	438/239
-	J	US-2001/0002708 / .	01-2001	Nakamura, Takashi	257/295
	к	US-5,889,299	03-1999	Abe et al.	257/295
-	L	US-			
_	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP02000286396A	10-2000	Japan	Hiyama et al.	H01L027/10
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.